

GSC6680

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

BVDSS	30V
RDS(ON)	11mΩ
ID	11.5A

Description

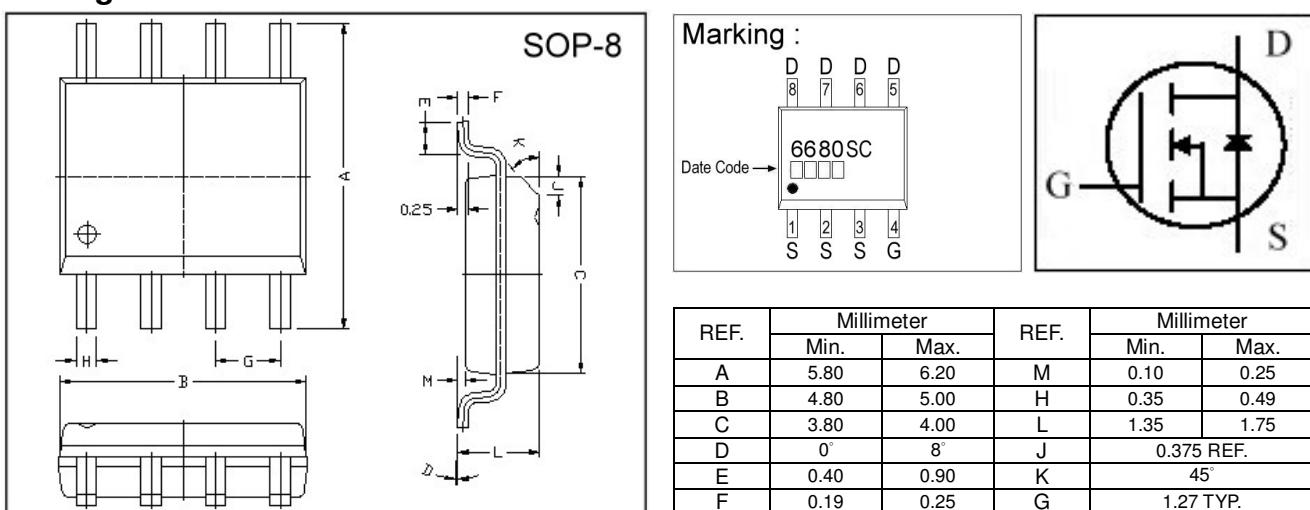
The GSC6680 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOP-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

Features

- *Low On-Resistance
- *High Vgs Max Rating Voltage
- *Surface Mount Package

Package Dimensions



Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current ³	I _D @TA=25°C	11.5	A
Continuous Drain Current ³	I _D @TA=70°C	9.5	A
Pulsed Drain Current ¹	I _{DM}	50	A
Total Power Dissipation	P _D @TA=25°C	2.5	W
Linear Derating Factor		0.02	W/°C
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 ~ +150	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient ³ Max.	R _{thj-amb}	50	°C/W

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	30	-	-	V	$\text{V}_{\text{GS}}=0$, $\text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	0.02	-	$\text{V}/^\circ\text{C}$	Reference to 25°C , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	1.0	-	3.0	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}$, $\text{I}_D=250\mu\text{A}$
Forward Transconductance	g_{fs}	-	30	-	S	$\text{V}_{\text{DS}}=15\text{V}$, $\text{I}_D=11.5\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	$\text{I}_{\text{DS}(\text{S})}$	-	-	1	uA	$\text{V}_{\text{DS}}=30\text{V}$, $\text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=70^\circ\text{C}$)		-	-	25	uA	$\text{V}_{\text{DS}}=24\text{V}$, $\text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance ²	$\text{R}_{\text{DS}(\text{ON})}$	-	-	11	$\text{m}\Omega$	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=11.5\text{A}$
		-	-	18		$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=9.5\text{A}$
Total Gate Charge ²	Q_g	-	16.8	-	nC	$\text{I}_D=11.5\text{A}$ $\text{V}_{\text{DS}}=15\text{V}$ $\text{V}_{\text{GS}}=5\text{V}$
Gate-Source Charge	Q_{gs}	-	4.2	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	8	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	8.9	-	ns	$\text{V}_{\text{DS}}=15\text{V}$ $\text{I}_D=1\text{A}$ $\text{V}_{\text{GS}}=10\text{V}$ $\text{R}_G=5.5\Omega$ $\text{R}_D=10\Omega$
Rise Time	T_r	-	7.3	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	25.6	-		
Fall Time	T_f	-	18.6	-		
Input Capacitance	C_{iss}	-	1450	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=25\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	285	-		
Reverse Transfer Capacitance	C_{rss}	-	180	-		

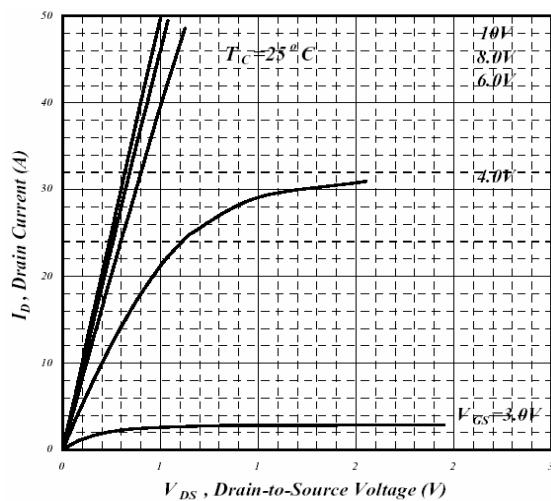
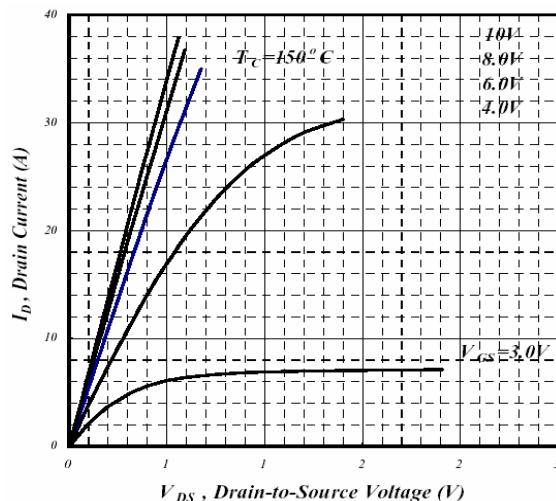
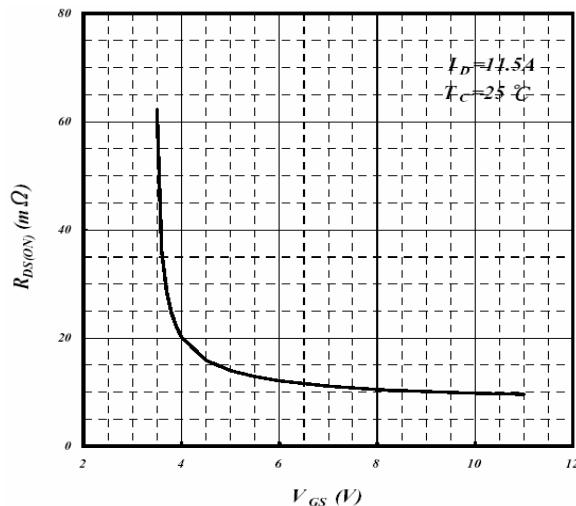
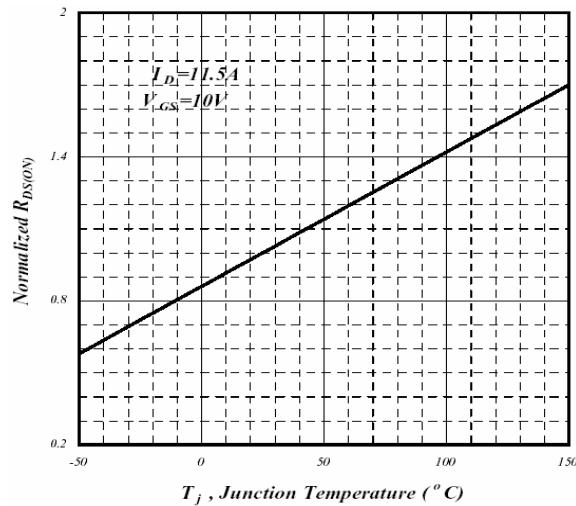
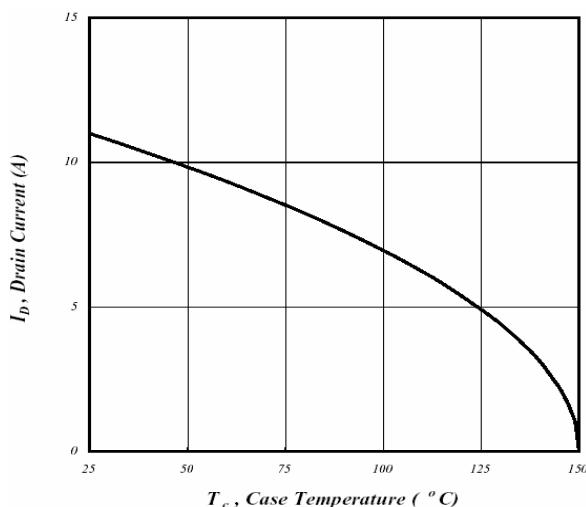
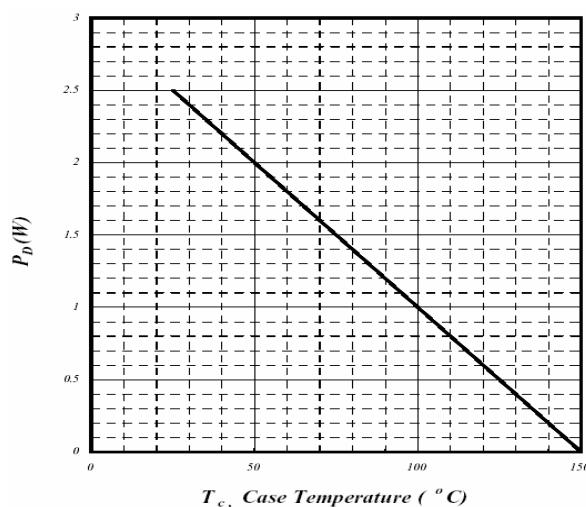
Source-Drain Diode

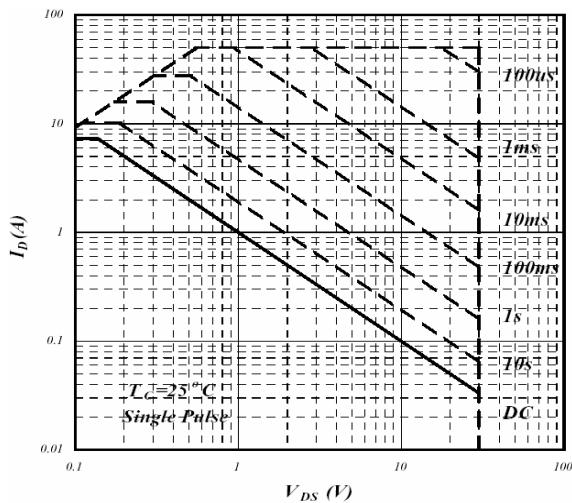
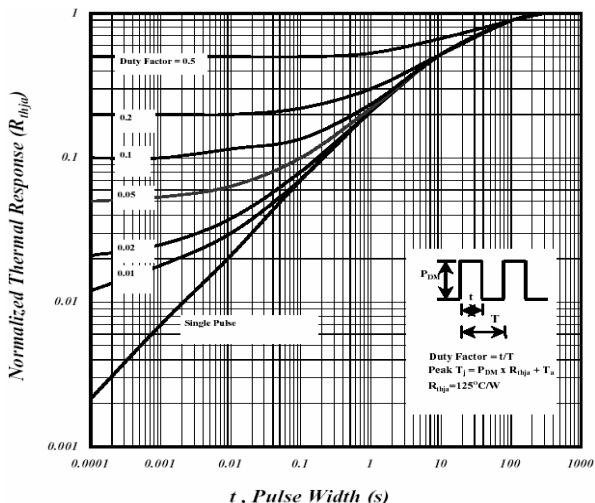
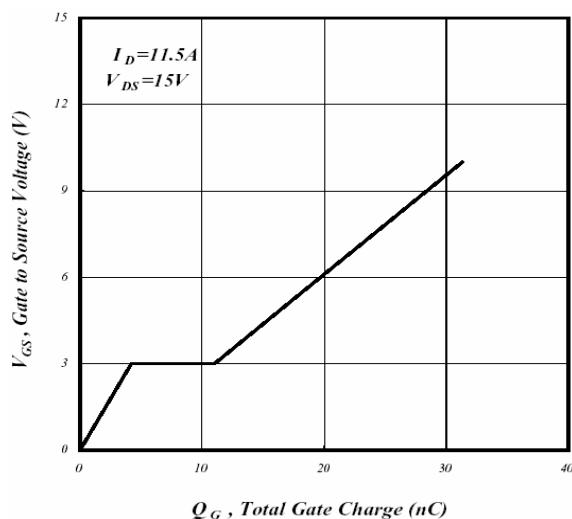
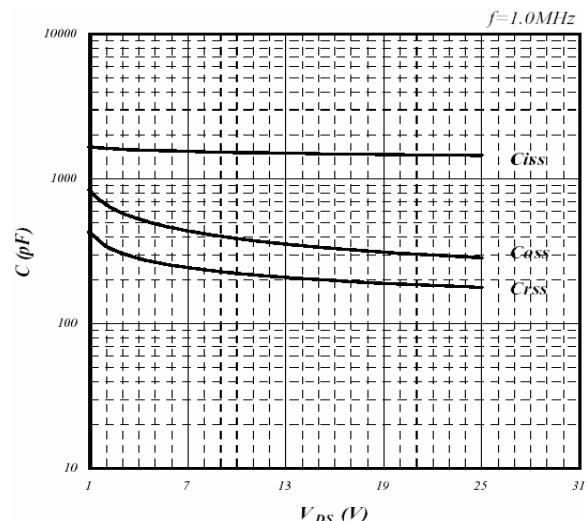
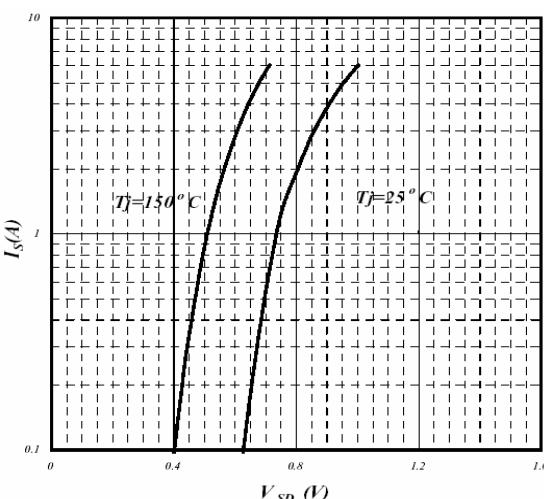
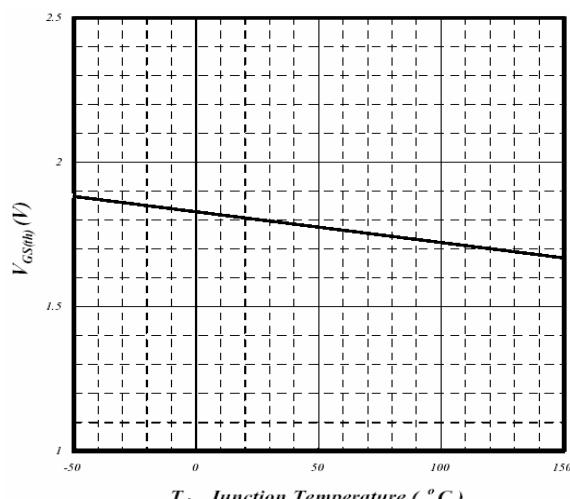
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	1.3	V	$\text{I}_S=3.5\text{A}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_j=25^\circ\text{C}$
Continuous Source Current (Body Diode)	I_S	-	-	1.92	A	$\text{V}_D=\text{V}_G=0\text{V}$, $\text{V}_S=1.3\text{V}$

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

3. Surface mounted on 1 in² copper pad of FR4 board; $125^\circ\text{C}/\text{W}$ when mounted on Min. copper pad.

Characteristics Curve**Fig 1. Typical Output Characteristics****Fig 2. Typical Output Characteristics****Fig 3. On-Resistance v.s. Gate Voltage****Fig 4. Normalized On-Resistance v.s. Junction Temperature****Fig 5. Maximum Drain Current v.s. Case Temperature****Fig 6. Type Power Dissipation**

**Fig 7. Maximum Safe Operating Area****Fig 8. Effective Transient Thermal Impedance****Fig 9. Gate Charge Characteristics****Fig 10. Typical Capacitance Characteristics****Fig 11. Forward Characteristics of Reverse Diode****Fig 12. Gate Threshold Voltage v.s. Junction Temperature**

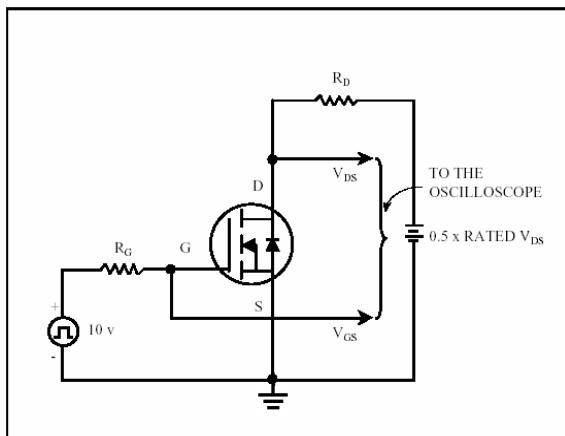


Fig 13. Switching Time Circuit

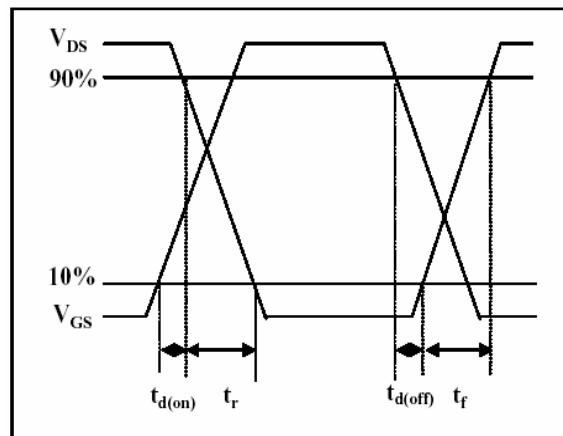


Fig 14. Switching Time Waveform

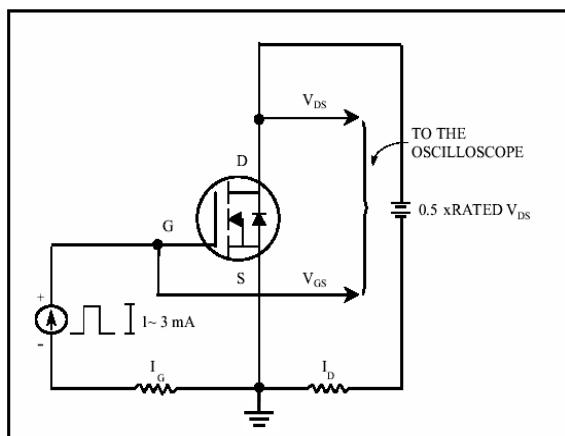


Fig 15. Gate Charge Circuit

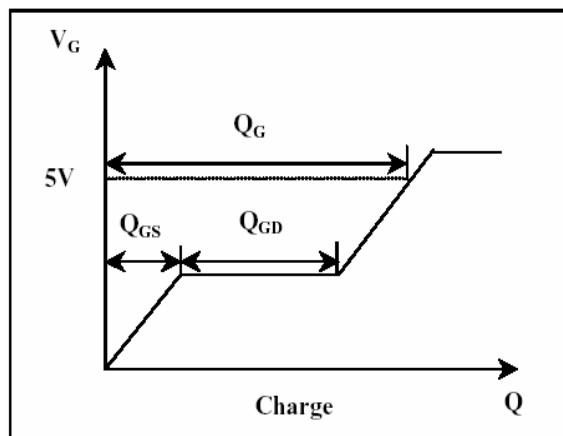


Fig 16. Gate Charge Waveform

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